Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/540,852	OKAJIMA ET AL.
Examiner	Art Unit
Sean E. Aeder	1642

SEARCHED						
Class	Subclass	Date	Examiner			

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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

(INCLUDING SEARCH	ľ ·	,
	DATE	EXMR
STN (MEDLINE, BIOSIS, EMBASE, SCISEARCH, DISSABS; attached), MEDLINE, WEST (PGPB, USPT, USOC, EPAB, JPAB, DWPI; attached)	7/17/2007	SEA
PALM inventor search	7/17/2007	SEA